

**Search Notes****Application/Control No.**

10/623,210

**Examiner**

Andrew Lee

**Applicant(s)/Patent under  
Reexamination**

LEAHY ET AL.

**Art Unit**

2616

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See EAST		4/23/2008	AL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor and Interference Search See EAST	4/23/2008	AL